

# SRM2B256SLMT 55/70/10



## 256K-Bit Static RAM

- Wide Temperature Range
- Extremely Low Standby Current
- Access Time 100ns (2.7V) /55ns (4.5V)
- 32,768 Words x 8-bit Asynchronous

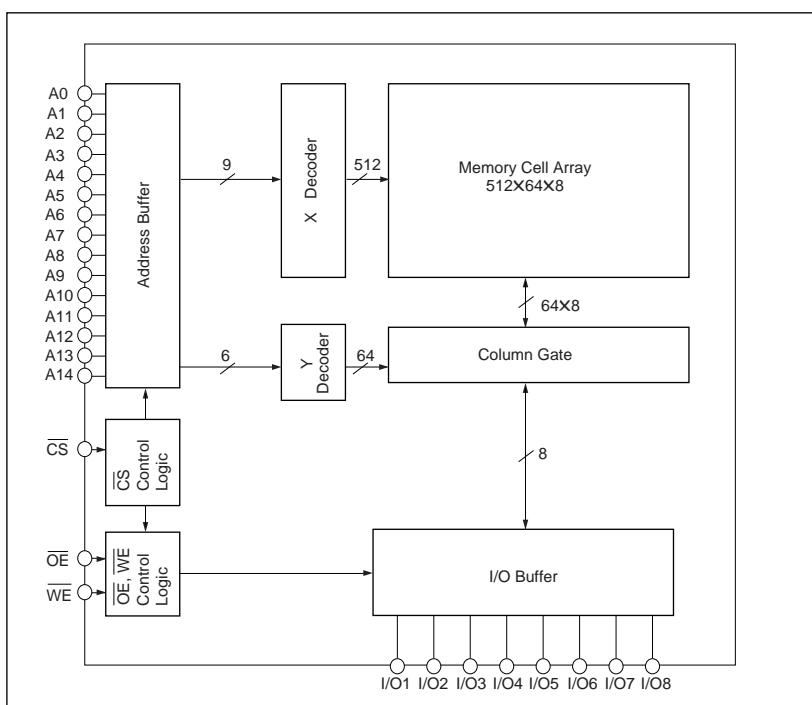
### ■ DESCRIPTION

The SRM2B256SLMT is a low voltage operating 32,768 wordsX8-bit asynchronous, static, random access memory fabricated using an advanced CMOS technology. Its very low standby power consumption makes it ideal for applications requiring non-volatile storage with back-up batteries. And -40 to 85°C operating temperature range makes it ideal for industrial use. The asynchronous and static nature of the memory requires no external clock or refresh circuit. Output ports are 3-state output allows easy expansion of memory capacity. These features makes the SRM2B256SLMT usable for wide range of applications from microprocessor systems to terminal devices.

### ■ FEATURES

- Wide temperature range ..... -40 to 85°C
- Extended supply voltage range ..... 2.7 to 5.5V
- Fast access time ..... 100ns (3V±10%)  
55ns (5V±10%)
- Extremely low standby current ..... SL Version
- Completely static ..... no clock required
- 3-state output
- Battery back-up operation
- Package ..... SRM2B256SLCT DIP2-28pin (plastic)  
SRM2B256SLMT SOP2-28pin (plastic)  
SRM2B256SLTMT TSOP (I) -28pin (plastic)  
SRM2B256SLRMT TSOP (I) -28pin-R1 (plastic)

### ■ BLOCK DIAGRAM



### ■ PIN CONFIGURATION

(DIP/SOP2)	
A14	1
A12	2
A7	3
A6	4
A5	5
A4	6
A3	7
A2	8
A1	9
A0	10
I/O1	11
I/O2	12
I/O3	13
V <sub>SS</sub>	14
V <sub>DD</sub>	28
WE	27
SRM2B256SLMT	26
A13	25
A9	24
A8	23
A7	22
OE	21
A10	20
CS	19
I/O8	18
A11	17
I/O6	16
I/O5	15
I/O4	14
V <sub>SS</sub>	13
I/O3	12
I/O2	11
A0	10
A1	9
I/O4	8

(TSOP)	
OE	22
A11	23
A9	24
A8	25
A13	26
WE	27
V <sub>DD</sub>	28
SRM2B256SLTMT	21
A14	20
A12	19
A7	18
A6	17
A5	16
A4	15
A3	14
V <sub>SS</sub>	13
I/O3	12
I/O2	11
I/O1	10
A0	9
A1	8

(TSOP-R1)(Reverse bending)	
A3	7
A4	6
A5	5
A6	4
A7	3
A12	2
A14	1
V <sub>DD</sub>	8
SRM2B256SLRMT	9
WE	10
A13	11
A12	12
A7	13
A6	14
A5	15
A4	16
A3	17
V <sub>SS</sub>	18
I/O6	19
I/O7	20
I/O8	21
A11	22
OE	23

### ■ PIN DESCRIPTION

A0 to A14	Address Input
WE	Write Enable
OE	Output Enable
CS	Chip Select
I/O1 to I/O8	Data Input/Output
V <sub>DD</sub>	Power Supply (2.7 to 5.5V)
V <sub>SS</sub>	Power Supply (0V)

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## ■ ABSOLUTE MAXIMUM RATINGS

(V<sub>SS</sub>=0V)

Parameter	Symbol	Rating	Unit
Supply voltage	V <sub>DD</sub>	-0.5 to 7.0	V
Input voltage	V <sub>I</sub>	-0.5* to 7.0	V
Input/Output voltage	V <sub>I/O</sub>	-0.5* to V <sub>DD</sub> +0.3	V
Power dissipation	P <sub>D</sub>	1.0	W
Operating temperature	T <sub>opr</sub>	-40 to 85	°C
Storage temperature	T <sub>stg</sub>	-65 to 150	°C
Soldering temperature and time	T <sub>sol</sub>	260°C, 10s(Lead only)	-

\*V<sub>I</sub>, V<sub>I/O</sub> (Min.)= -3.0V when pulse width is less or equal to 50ns

## ■ DC RECOMMENDED OPERATING CONDITIONS

(V<sub>SS</sub>=0V, Ta= -40 to 85°C)

Parameter	Symbol	V <sub>DD</sub> =3V±10%			V <sub>DD</sub> =5V±10%			Unit
		Min.	Typ.	Max.	Min.	Typ.	Max.	
Supply voltage	V <sub>DD</sub>	2.7	-	3.3	4.5	-	5.5	V
	V <sub>SS</sub>	0	-	0	0	-	0	V
Input voltage	V <sub>IH</sub>	2.2	-	V <sub>DD</sub> +0.3	2.2	-	V <sub>DD</sub> +0.3	V
	V <sub>IL</sub>	-0.3*	-	0.4	-0.3*	-	0.8	V

\*V<sub>IL</sub> (Min.)= -3V when pulse width is less or equal to 50ns

## ■ ELECTRICAL CHARACTERISTICS

### ● DC Electrical Characteristics

(V<sub>SS</sub>=0V, Ta= -40 to 85°C)

Parameter	Symbol	Conditions	V <sub>DD</sub> =3V±10%			V <sub>DD</sub> =5V±10%			Unit
			Min.	Typ.*1	Max.	Min.	Typ.*2	Max.	
Input leakage	I <sub>LI</sub>	V <sub>I</sub> =0 to V <sub>DD</sub>	-1.0	-	1.0	-1.0	-	1.0	μA
Standby supply current	I <sub>DDS</sub>	CS=V <sub>IH</sub>	-	-	2	-	-	3	mA
	I <sub>DDS1</sub>	CS≥V <sub>DD</sub> -0.2V	-	0.3	25	-	0.5	50	μA
Average operating current	I <sub>DDA</sub>	V <sub>I</sub> =V <sub>IL</sub> , V <sub>IH</sub> I <sub>I/O</sub> =0mA, t <sub>cyc</sub> =Min.	-	10	15	-	30	45	mA
	I <sub>DDA1</sub>	V <sub>I</sub> =V <sub>IL</sub> , V <sub>IH</sub> I <sub>I/O</sub> =0mA, t <sub>cyc</sub> =1μs	-	-	5	-	-	10	mA
Operating supply current	I <sub>DDO</sub>	V <sub>I</sub> =V <sub>IL</sub> , V <sub>IH</sub> I <sub>I/O</sub> =0mA	-	-	5	-	-	10	mA
Output leakage	I <sub>LO</sub>	CS=V <sub>IH</sub> or WE=V <sub>IL</sub> or OE=V <sub>IH</sub> , V <sub>I/O</sub> =0 to V <sub>DD</sub>	-1.0	-	1.0	-1.0	-	1.0	μA
High level output voltage	V <sub>OH</sub>	I <sub>OH</sub> =-1.0mA, -0.5mA*3	2.4	-	-	2.4	-	-	V
Low level output voltage	V <sub>OL</sub>	I <sub>OL</sub> =2.1mA, 1.0mA*3	-	-	0.4	-	-	0.4	V

\*1 Typical values are measured at Ta=25°C and V<sub>DD</sub>=3.0V\*2 Typical values are measured at Ta=25°C and V<sub>DD</sub>=5.0V\*3 V<sub>DD</sub>=3V±10%

### ● Terminal Capacitance

(f=1MHz, Ta=25°C)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Input Capacitance	C <sub>I</sub>	V <sub>I</sub> =0V	-	-	8	pF
I/O Capacitance	C <sub>I/O</sub>	V <sub>I/O</sub> =0V	-	-	10	pF

Note : This parameter is made by the inspection data of sample, not for all products.

### ● AC Electrical Characteristics

#### ○ Read Cycle

(V<sub>SS</sub>=0V, Ta= -40 to 85°C)

Parameter	Symbol	Conditions	SRM2B256SLMT55		SRM2B256SLMT70		SRM2B256SLMT10		Unit							
			V <sub>DD</sub> =3V±10% V <sub>DD</sub> =5V±10%		V <sub>DD</sub> =3V±10% V <sub>DD</sub> =5V±10%		V <sub>DD</sub> =3V±10% V <sub>DD</sub> =5V±10%									
			Min.	Max.	Min.	Max.	Min.	Max.								
Read cycle time	t <sub>RC</sub>	*1	100	-	55	-	120	-	70	-	180	-	100	-	nS	
Address access time	t <sub>ACC</sub>		-	100	-	55	-	120	-	70	-	180	-	100	-	nS
CS access time	t <sub>ACS</sub>		-	100	-	55	-	120	-	70	-	180	-	100	-	nS
OE access time	t <sub>OE</sub>		-	60	-	30	-	70	-	35	-	90	-	45	-	nS
CS output set time	t <sub>CLZ</sub>	*2	15	-	10	-	15	-	10	-	15	-	10	-	-	nS
CS output floating	t <sub>CHZ</sub>		-	35	-	20	-	40	-	25	-	50	-	35	-	nS
OE output set time	t <sub>OLZ</sub>		5	-	5(0)	-	5	-	5(0)	-	5	-	5(0)	-	-	nS
OE output floating	t <sub>OHZ</sub>		-	35	-	20	-	40	-	25	-	50	-	35	-	nS
Output hold time	t <sub>OH</sub>	*1	15	-	10	-	15	-	10	-	15	-	10	-	-	nS

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SRM2B256SLMT 55/70/10

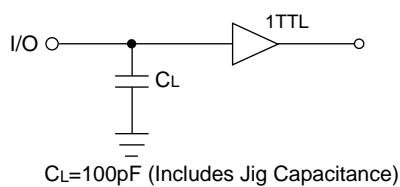
## ○ Write Cycle

(V<sub>SS</sub>=0V, T<sub>a</sub>=-40 to 85°C)

Parameter	Symbol	Conditions	SRM2B256SLMT55		SRM2B256SLMT70		SRM2B256SLMT10		Unit							
			V <sub>DD</sub> =3V±10%		V <sub>DD</sub> =5V±10%		V <sub>DD</sub> =3V±10%									
			Min.	Max.	Min.	Max.	Min.	Max.								
Write cycle time	t <sub>WC</sub>	*1	100	-	55	-	120	-	70	-	180	-	100	-	nS	
Chip select time	t <sub>CW</sub>		80	-	50	-	90	-	60	-	110	-	80	-	nS	
Address valid to end of write	t <sub>AW</sub>		80	-	50	-	90	-	60	-	110	-	80	-	nS	
Address setup time	t <sub>AS</sub>		0	-	0	-	0	-	0	-	0	-	0	-	nS	
Write pulse width	t <sub>WP</sub>		75	-	40	-	80	-	45	-	100	-	60	-	nS	
Address hold time	t <sub>WR</sub>		0	-	0	-	0	-	0	-	0	-	0	-	nS	
Input data set time	t <sub>DW</sub>		40	-	25	-	45	-	30	-	60	-	40	-	nS	
Input data hold time	t <sub>DH</sub>		0	-	0	-	0	-	0	-	0	-	0	-	nS	
Write to Output floating	t <sub>WHZ</sub>	*2	-	-	35	-	20	-	40	-	25	-	50	-	35	nS
Output Active from end to write	t <sub>OW</sub>		5	-	5	-	5	-	5	-	5	-	5	-	nS	

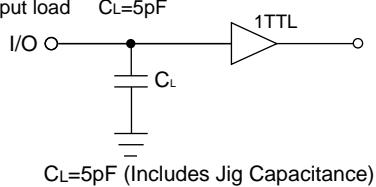
\*1 Test Conditions

1. Input pulse level: 0.6V to 2.4V
2. t<sub>r</sub>=t<sub>f</sub>=5ns
3. Input and output timing reference levels : 1.5V
4. Output load C<sub>L</sub>=100pF

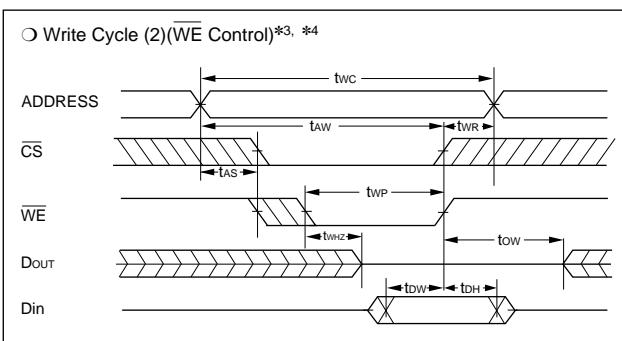
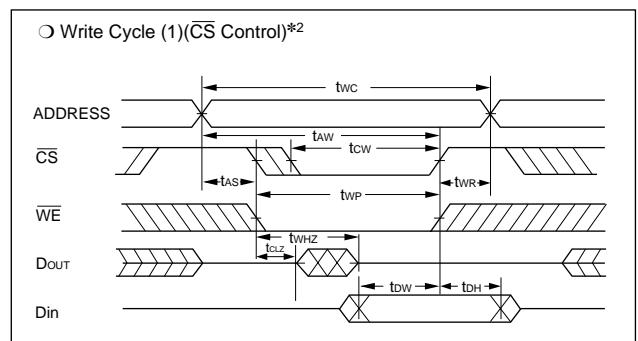
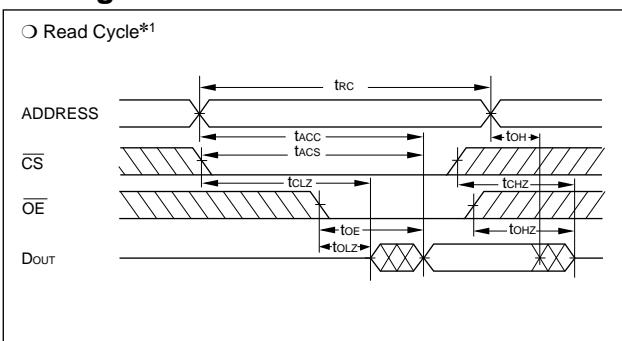


\*2 Test Conditions

1. Input pulse level : 0.6V to 2.4V
2. t<sub>r</sub>=t<sub>f</sub>=5ns
3. Input timing reference levels : 1.5V
4. Output timing reference levels:  
±200mV (the level displaced from stable output voltage level)
5. Output load C<sub>L</sub>=5pF



## ● Timing chart



## Note :

- \* 1 During read cycle time, WE is to be "H" level.
- \* 2 During write cycle time that is controlled by CS, Output Buffer is in high impedance state, whether OE level is "H" or "L".
- \* 3 During write cycle time that is controlled by WE, Output Buffer is in high impedance state if OE is "H" level.
- \* 4 When I/O terminals are output mode, be careful that do not give the opposite signals to the terminals.

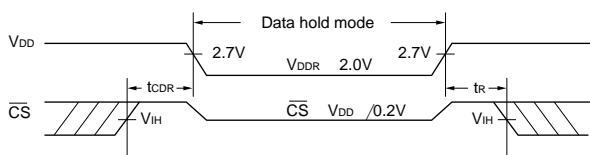
## ■ DATA RETENTION CHARACTERISTIC WITH LOW VOLTAGE POWER SUPPLY

(V<sub>SS</sub>=0V, Ta=-40 to 40°C)

Parameter	Symbol	Conditions	Min.	Typ.*1	Max.	Unit
Data retention Supply voltage	V <sub>DDR</sub>		2.0	—	5.5	V
Data retention current	I <sub>DDR</sub>	V <sub>DD</sub> =3V, CS≥V <sub>DD</sub> -0.2V	-40 to 85°C	—	0.25	20 μA
			0 to 70°C	—	0.25	10 μA
			0 to 40°C	—	0.25	2 μA
Chip select data hold time	t <sub>CDR</sub>		0	—	—	ns
Operation recovery time	t <sub>R</sub>		5	—	—	ms

\*1 Typical values are measured at 25 °C

### Data retention timing



Note: During standby mode in which the data is retentive, the supply voltage (V<sub>DD</sub>) can be in low voltage until V<sub>DD</sub>=V<sub>DDR</sub>. At this mode data reading and writing are impossible.

## ■ FUNCTIONS

### ● Truth Table

CS	OE	WE	A0 to A14	DATA I/O	Mode	I <sub>DD</sub>
H	X	X	—	Hi-Z	Standby	I <sub>DDS</sub> , I <sub>DDSI</sub>
L	X	L	Stable	D <sub>IN</sub>	Write	I <sub>DDA</sub> , I <sub>DDA1</sub>
L	L	H	Stable	D <sub>OUT</sub>	Read	I <sub>DDA</sub> , I <sub>DDA1</sub>
L	H	H	Stable	Hi-Z	Output disable	I <sub>DDA</sub> , I <sub>DDA1</sub>

X : "H" or "L", — "H", "L" or "Hi-Z"

### ● Read Mode

The data appear when the address is set while holding CS="L" OE="L" and WE="H". When OE="H", DATA I/O terminals are in high impedance state, that makes circuit design and bus control easy.

### ● Write Mode

There are the following 3 ways of writing data into memory.

- (1) Hold CS="L" and WE="L", set address
- (2) Hold CS="L" then set address and give "L"pulse to WE.
- (3) After setting addresses, give "L"pulse to both CS and WE.

In above any case data on the DATA I/O terminals are latched up into the chip when CS or WE is in positive-going. Since DATA I/O terminals are high impedance when CS or OE="H", bus contention between data driver and memory outputs can be avoided.

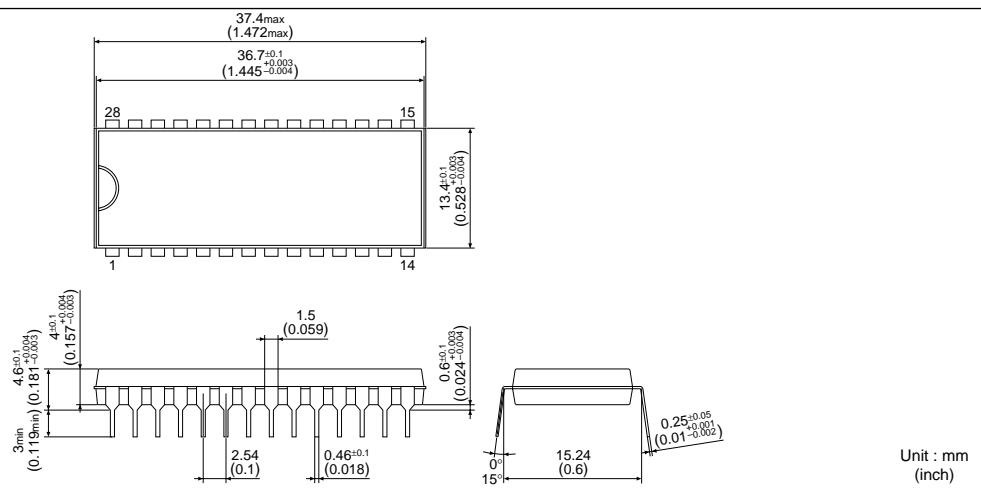
### ● Standby Mode

When CS is "H" the chip become in the standby mode. In this mode, DATA I/O terminals are high impedance and all inputs of addresses, WE and data can be any "H"or "L". When CS is over than V<sub>DD</sub>-0.2V, the chip is in the data retention battery backup mode, in this case, there is a small current in the chip which flow through the high resistances of the memory cells.

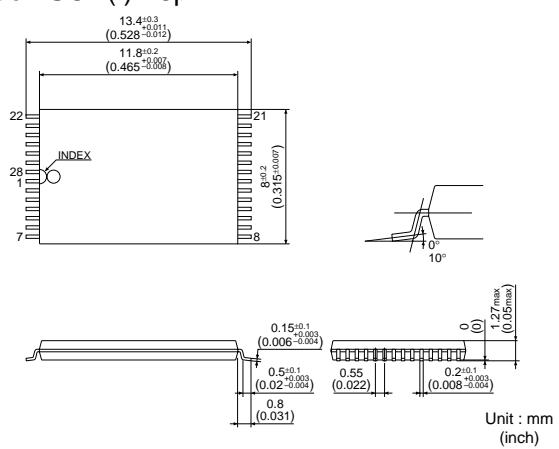
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## ■ PACKAGE DIMENSIONS

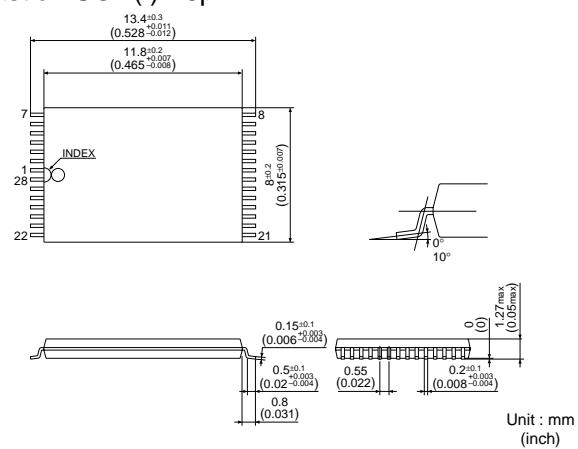
Plastic DIP-28pin



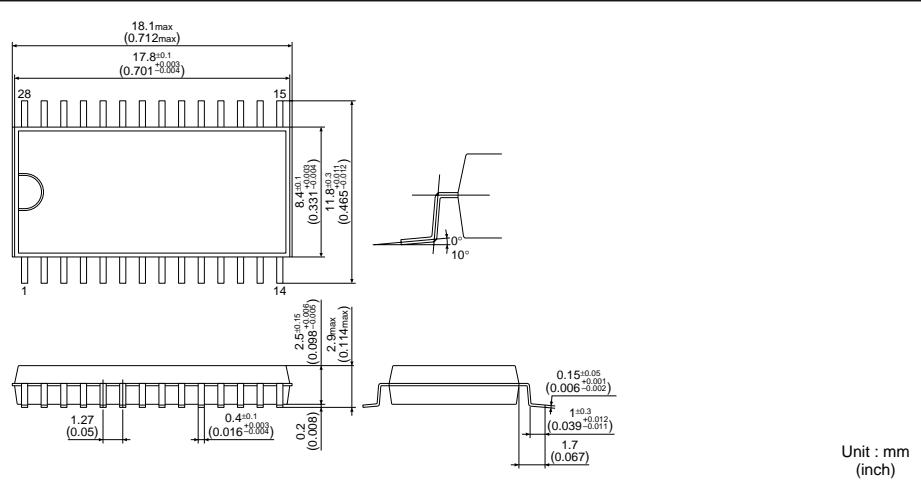
Plastic TSOP(I)-28pin



Plastic TSOP(I)-28pin-R1

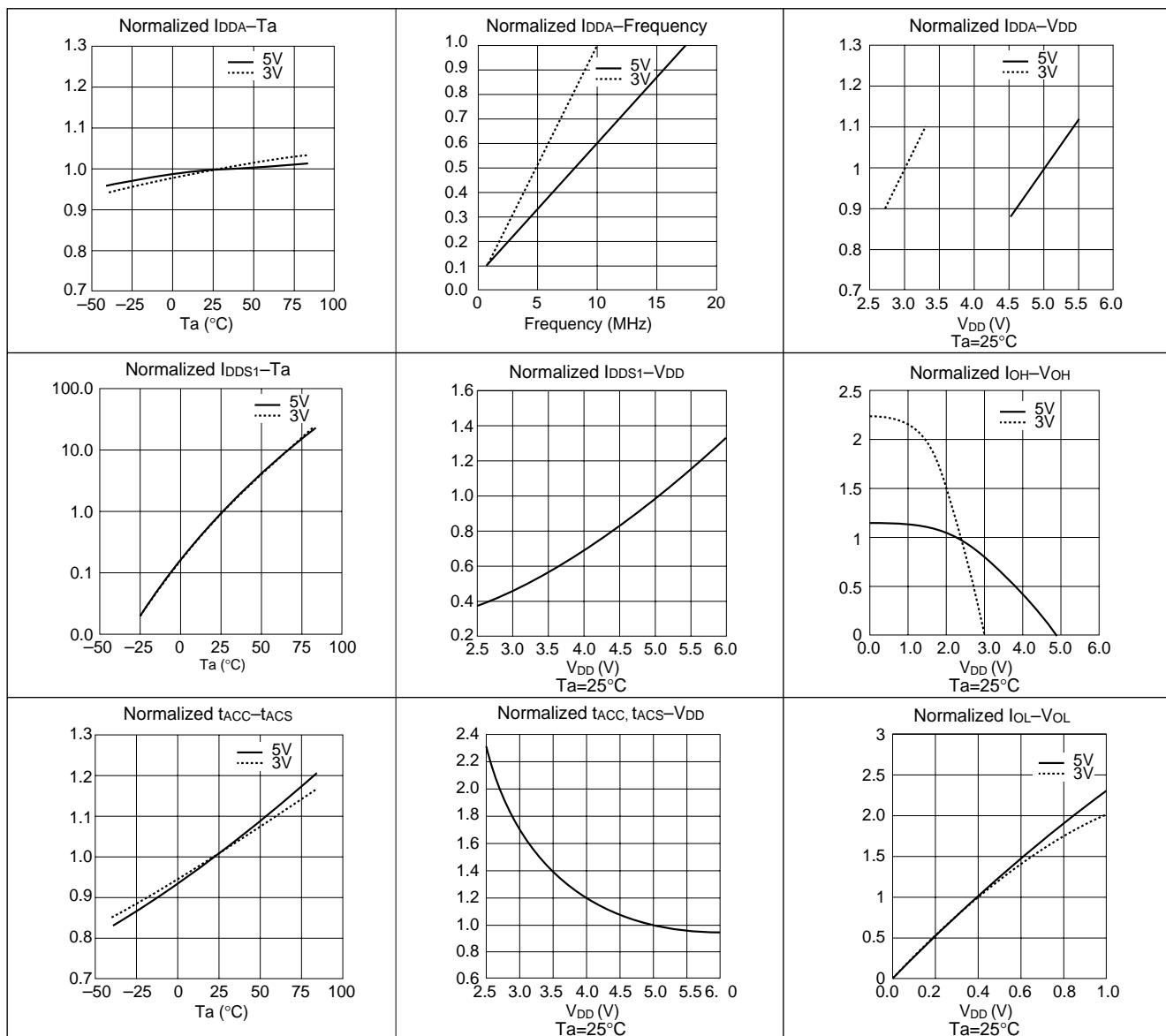


Plastic SOP2-28pin



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## ■ CHARACTERISTICS CURVES



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